

# UNISONIC TECHNOLOGIES CO., LTD

7N65-LD **Preliminary Power MOSFET** 

# 7.0A, 650V N-CHANNEL POWER MOSFET

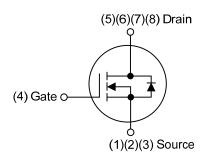
#### **DESCRIPTION**

The UTC 7N65-LD is a high voltage power MOSFET combines advanced trench MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

#### **FEATURES**

- \*  $R_{DS(ON)} \le 1.7 \Omega @ V_{GS} = 10V, I_D = 3.5A$
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

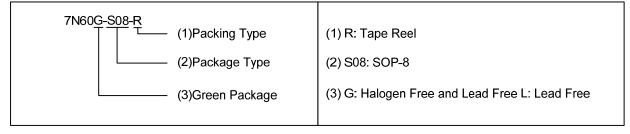
#### **SYMBOL**



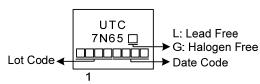
#### ORDERING INFORMATION

Ordering Number		Daalaaaa	Pin Assignment						Daaliaa		
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
7N60L-S08-R	7N60G-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



#### **MARKING**



SOP-8

www.unisonic.com.tw 1 of 5

### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	650	V
Gate-Source Voltage		$V_{GSS}$	±30	V
Continuous Drain Current		$I_{D}$	7	Α
Pulsed Drain Current (Note 2)		$I_{DM}$	14	Α
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	264	mJ
Power Dissipation		$P_{D}$	2.5	W
Junction Temperature		T <sub>J</sub>	+150	°C
Storage Temperature	_	T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 30mH,  $I_{AS}$  = 4.2A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C

# ■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT		
Junction to Ambient	$\theta_{JA}$	190	°C/W		
Junction to Case	θ <sub>JC</sub>	50	°C/W		

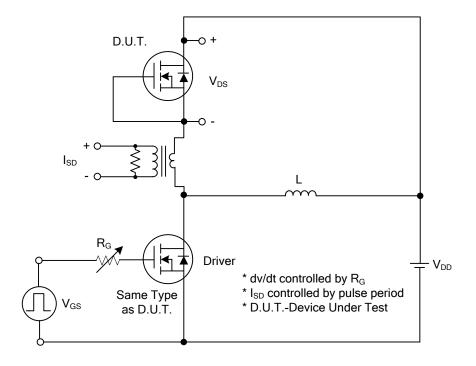
# ■ ELECTRICAL CHARACTERISTICS (T」=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	LINIT		
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	650			V		
		_	00 , 5	030		10	μA		
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			100	nΑ		
Gate- Source Leakage Current	Forward	$I_{GSS}$	$V_{GS}$ =30V, $V_{DS}$ =0V						
ON OUADACTEDICTION	Reverse	_	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.0		4.0	V		
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	$V_{GS}$ =10V, $I_D$ =3.5A			1.7	Ω		
DYNAMIC CHARACTERISTICS									
Input Capacitance		C <sub>ISS</sub>			888		pF		
Output Capacitance		Coss	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0MHz		87		pF		
Reverse Transfer Capacitance		$C_{RSS}$			6		pF		
SWITCHING CHARACTERISTICS	6								
Total Gate Charge (Note 1)		$Q_{G}$	\\ -520\\ \\ -10\\   -74		24		nC		
Gate-Source Charge		$Q_GS$	$V_{DS}$ =520V, $V_{GS}$ =10V, $I_{D}$ =7A		8		nC		
Gate-Drain Charge		$Q_GD$	I <sub>G</sub> =1mA (Note 1, 2)		2		nC		
Turn-On Delay Time (Note 1)		$t_{D(ON)}$			10		ns		
Turn-On Rise Time		$t_R$	$V_{DS}$ =100V, $V_{GS}$ =10V, $I_{D}$ =7A,		17		ns		
Turn-Off Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		57		ns		
Turn-Off Fall Time		$t_{F}$			29		ns		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS									
Maximum Body-Diode Continuous Current		Is				7	Α		
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				14	Α		
Drain-Source Diode Forward Voltage (Note 1)		$V_{SD}$	I <sub>S</sub> =7A , V <sub>GS</sub> =0V			1.4	V		

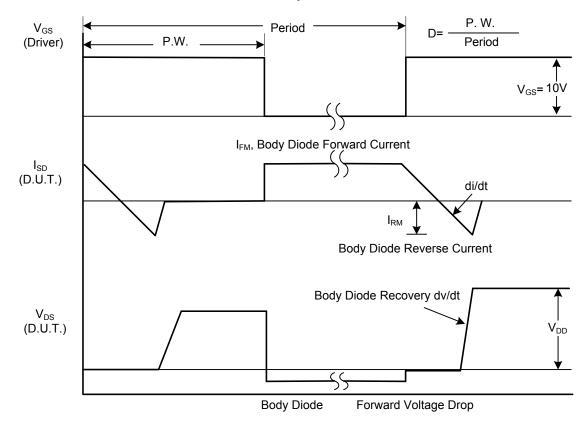
Notes: 1. Pulse Test: Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2%.

2. Essentially independent of operating temperature.

#### ■ TEST CIRCUITS AND WAVEFORMS

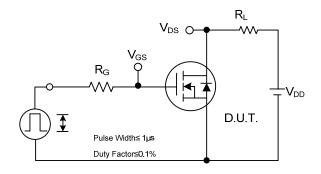


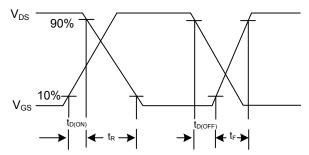
# Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

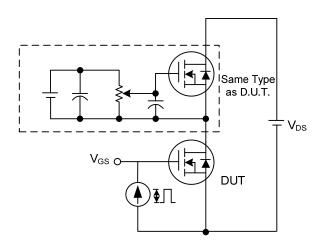
### ■ TEST CIRCUITS AND WAVEFORMS

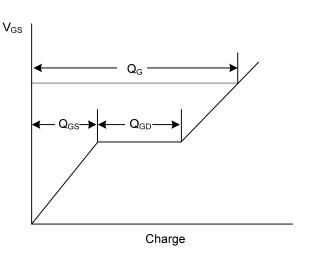




**Switching Test Circuit** 

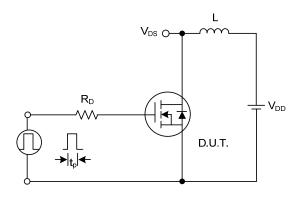
**Switching Waveforms** 

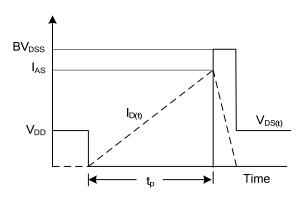




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

UTC assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all UTC products described or contained herein. UTC products are not designed for use in life support appliances, devices or systems where malfunction of these products can be reasonably expected to result in personal injury. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner. UTC reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

